

Notice of References Cited	Application/Control No. 10/585,846		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner PATRICK F. RIEGLER		Art Unit 2173	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0091739	07-2002	Ferlitsch et al.	707/526
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NON-PATENT DOCUMENTS

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